Notice of References Cited Application/Control No. 10/565,709 Examiner Meless N. Zewdu Applicant(s)/Patent Under Reexamination ABEDI, SAIED Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0169746 A1	09-2003	Kitazawa et al.	370/395.42
*	В	US-7,336,632 B2	02-2008	Cheng et al.	370/329
*	C	US-2004/0147276 A1	07-2004	Gholmieh et al.	455/522
*	D	US-2002/0155853 A1	10-2002	Lee et al.	455/522
*	Е	US-6,987,738 B2	01-2006	Subramanian et al.	370/252
*	F	US-2005/0047393 A1	03-2005	Liu, Jung-Tao	370/352
*	G	US-7,373,420 B1	05-2008	Lyon, Norman	709/235
*	Η	US-2003/0045288 A1	03-2003	Luschi et al.	455/434
*	I	US-7,020,110 B2	03-2006	Walton et al.	370/334
*	J	US-6,889,050 B1	05-2005	Willars et al.	455/452.2
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.